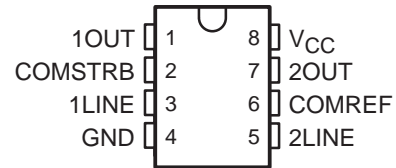


- Single 5-V Supply
- $\pm 100$ -mV Sensitivity
- For Application as:
  - Single-Ended Line Receiver
  - Gated Oscillator
  - Level Comparator
- Adjustable Reference Voltage
- TTL Outputs
- TTL-Compatible Strobe
- Designed for Party-Line (Data-Bus) Applications
- Common Reference-Voltage Pin
- Common Strobe

## P OR PS† PACKAGE (TOP VIEW)



† The PS package is only available left-ended taped and reeled (order SN75140 PSR).

## description

This device consists of a dual single-ended line receiver with TTL-compatible strobes and outputs. The reference voltage (switching threshold) is applied externally and can be adjusted from 1.5 V to 3.5 V, making it possible to optimize noise immunity for a given system design. Due to the low input current (less than 100  $\mu$ A), the device is suited ideally for party-line (data-bus) systems.

The SN75140 has a common reference-voltage pin and a common strobe.

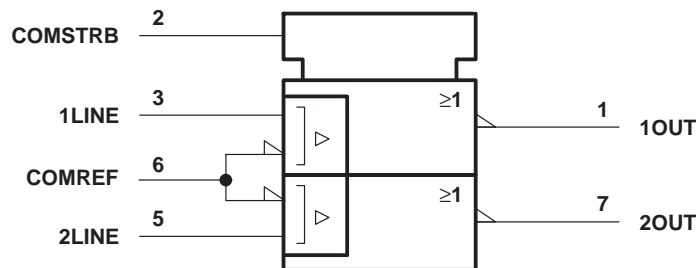
The SN75140 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE  
(each receiver)

LINE INPUT	STROBE	OUTPUT
$\leq V_{ref} - 100$ mV	L	H
$\geq V_{ref} + 100$ mV	X	L
X	H	L

H = high level, L = low level, X = irrelevant

## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

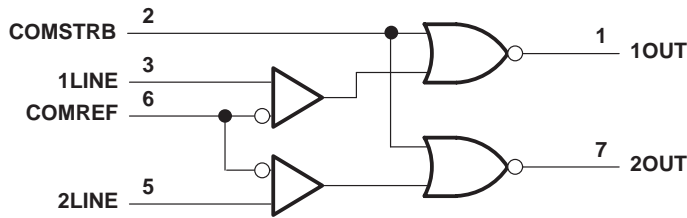
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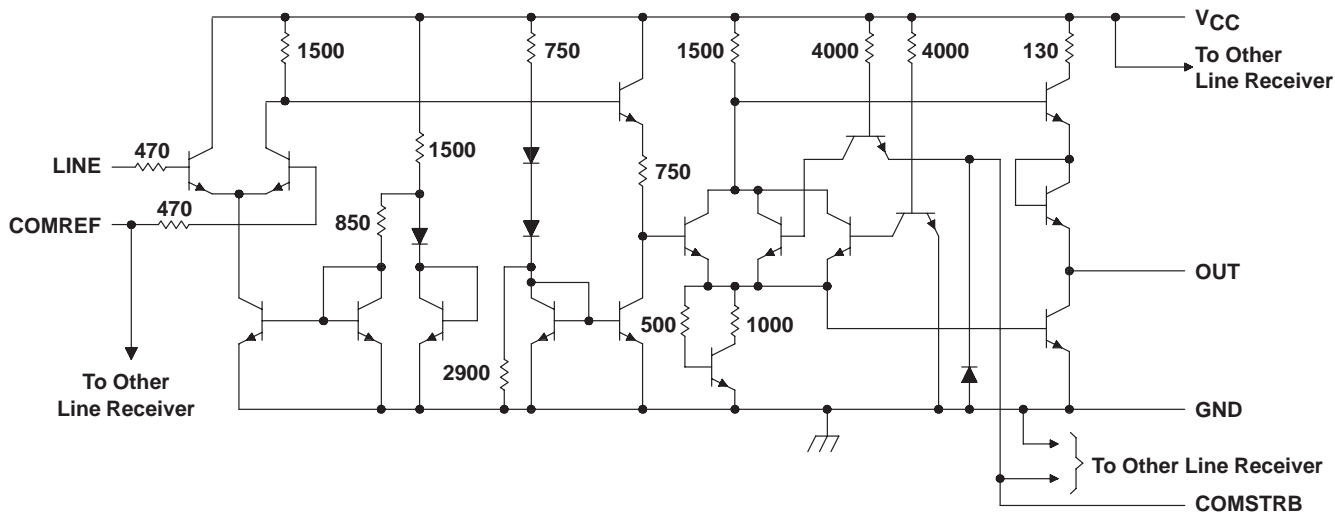
SN75140  
DUAL LINE RECEIVER

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logic diagram (positive logic)



schematic (each receiver)



NOTE: Resistor values shown are nominal and in ohms.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, $V_{CC}$ (see Note 1)	7 V
Reference input voltage, $V_{ref}$	5.5 V
Line input voltage range with respect to GND	-2 V to 5.5 V
Line input voltage with respect to $V_{ref}$	$\pm 5$ V
Strobe input voltage	5.5 V
Continuous total power dissipation	See Dissipation Rating Table
Storage temperature range, $T_{stg}$	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Unless otherwise specified, voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
P	1000 mW	8.0 mW/°C	640 mW
PS	450 mW	3.6 mW/°C	288 mW

**recommended operating conditions**

	MIN	NOM	MAX	UNIT
Supply voltage, $V_{CC}$	4.5	5	5.5	V
Reference input voltage, $V_{ref}$	1.5		3.5	V
High-level line input voltage, $V_{IH(L)}$	$V_{ref}+0.1$		$V_{CC}-1$	V
Low-level line input voltage, $V_{IL(L)}$	0		$V_{ref}-0.1$	V
High-level strobe input voltage, $V_{IH(S)}$	2		5.5	V
Low-level strobe input voltage, $V_{IL(S)}$	0		0.8	V
Operating free-air temperature range, $T_A$	0		70	°C

**electrical characteristics over recommended operating free-air temperature range,  $V_{CC} = 5\text{ V} \pm 10\%$ ,  $V_{ref} = 1.5\text{ V}$  to  $3.5\text{ V}$  (unless otherwise noted)**

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
$V_{IK}$	Strobe input clamp voltage	$I_I(S) = -12\text{ mA}$			-1.5	V
$V_{OH}$	High-level output voltage	$V_{IL(L)} = V_{ref} - 100\text{ mV}$ , $V_{IL(S)} = 0.8\text{ V}$ , $I_{OH} = -400\text{ }\mu\text{A}$	2.4			V
$V_{OL}$	Low-level output voltage	$V_{IH(L)} = V_{ref} + 100\text{ mV}$ , $V_{IL(S)} = 0.8\text{ V}$ , $I_{OL} = 16\text{ mA}$			0.4	V
		$V_{IL(L)} = V_{ref} - 100\text{ mV}$ , $V_{IH(S)} = 2\text{ V}$ , $I_{OL} = 16\text{ mA}$			0.4	
$I_I(S)$	Strobe input current at maximum input voltage	$V_I(S) = 5.5\text{ V}$			1	mA
	COMSTRB				2	
$I_{IH}$	High-level input current	Strobe			40	$\mu\text{A}$
		COMSTRB			80	
		LINE	$V_{I(L)} = 3.5\text{ V}$ , $V_{ref} = 1.5\text{ V}$	35	100	
		Reference	$V_{I(L)} = 0$ , $V_{ref} = 3.5\text{ V}$	35	100	
		COMREF		70	200	
$I_{IL}$	Low-level input current	Strobe			-1.6	mA
		COMSTRB	$V_I(S) = 0.4\text{ V}$		-3.2	
		LINE	$V_{I(L)} = 0$ , $V_{ref} = 1.5\text{ V}$		-10	$\mu\text{A}$
		Reference	$V_{I(L)} = 1.5\text{ V}$ , $V_{ref} = 0$		-10	
		COMREF			-20	
$I_{OS}$	Short-circuit output current‡	$V_{CC} = 5.5\text{ V}$	-18		-55	mA
$I_{CCH}$	Supply current, output high	$V_I(S) = 0$ , $V_{I(L)} = V_{ref} - 100\text{ mV}$		18	30	mA
$I_{CCL}$	Supply current, output low	$V_I(S) = 0$ , $V_{I(L)} = V_{ref} + 100\text{ mV}$		20	35	mA

† All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

‡ Only one output should be shorted at a time.

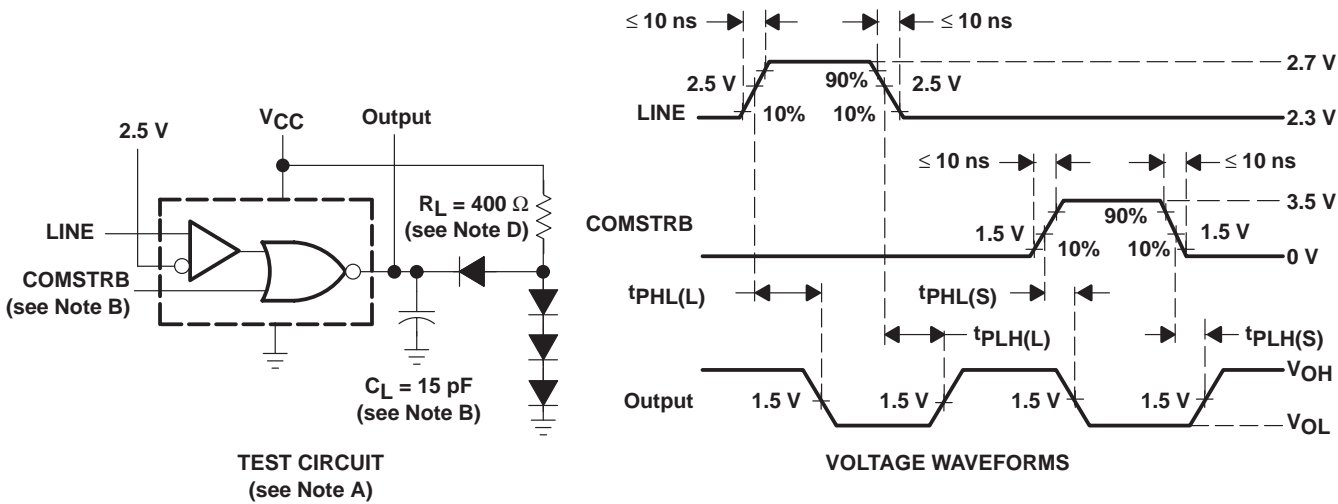
**switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $V_{ref} = 2.5\text{ V}$ ,  $T_A = 25^\circ\text{C}$**

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH(L)}$	Propagation delay time, low- to high-level output from LINE	$C_L = 15\text{ pF}$ , $R_L = 400\text{ k}\Omega$ , See Figure 1		22	35	ns
$t_{PHL(L)}$	Propagation delay time, high- to low-level output from LINE	$C_L = 15\text{ pF}$ , $R_L = 400\text{ k}\Omega$ , See Figure 1		22	30	ns
$t_{PLH(S)}$	Propagation delay time, low- to high-level output from COMSTRB	$C_L = 15\text{ pF}$ , $R_L = 400\text{ k}\Omega$ , See Figure 1		12	22	ns
$t_{PHL(S)}$	Propagation delay time, high- to low-level output from COMSTRB	$C_L = 15\text{ pF}$ , $R_L = 400\text{ k}\Omega$ , See Figure 1		8	15	ns

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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. Input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, duty cycle ≤ 50%, Z<sub>O</sub> = 50 Ω.  
B. Unused strobes are to be grounded.  
C. C<sub>L</sub> includes probe and jig capacitance.  
D. All diodes are 1N3064.

Figure 1. Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

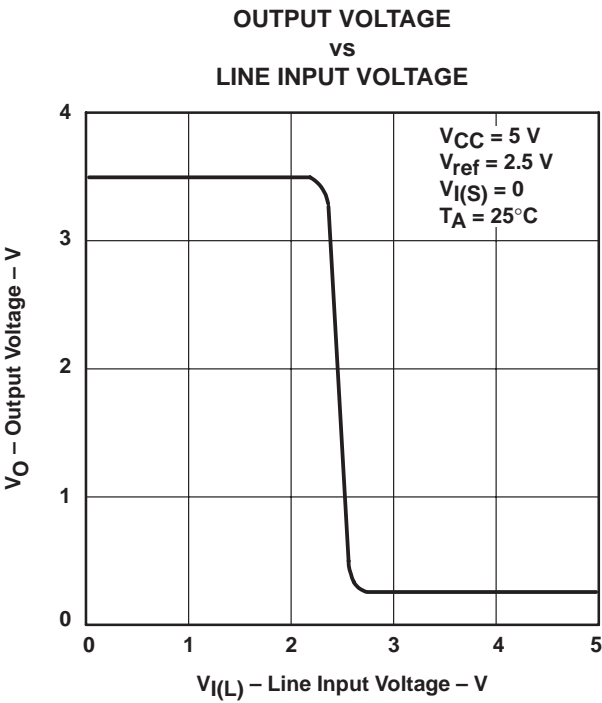


Figure 2

## APPLICATION INFORMATION

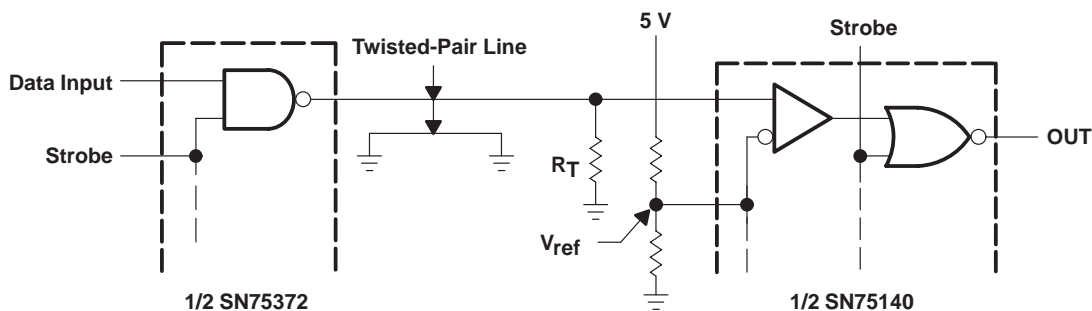
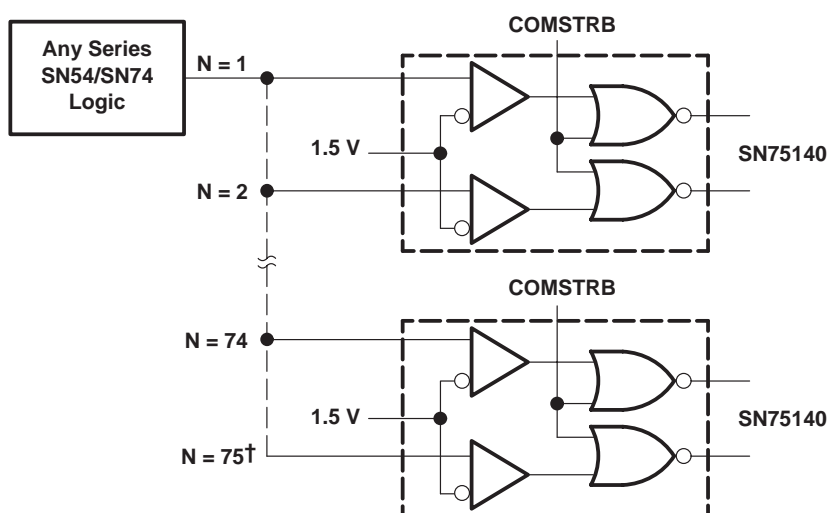


Figure 3. Line Receiver



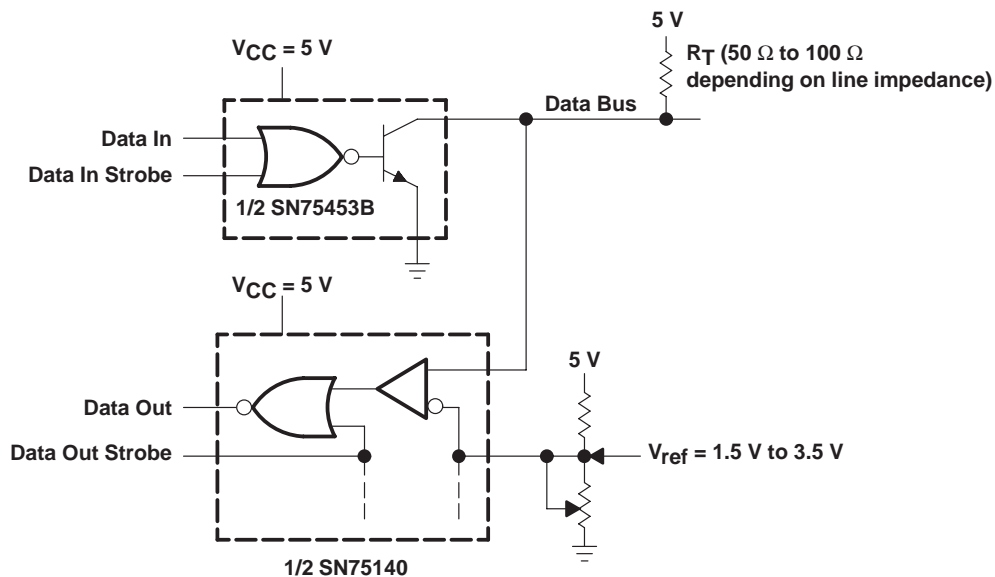
† Although most series SN54/SN74 circuits have a >2.4-V output at 400  $\mu$ A, they typically are capable of maintaining a >2.4-V output level under a load of 7.5 mA.

Figure 4. High Fanout From Standard TTL Gate

# SN75140 DUAL LINE RECEIVER

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## APPLICATION INFORMATION



NOTE A: Using this arrangement, as many as 100 transceivers can be connected to a single data bus. The adjustable reference-voltage feature allows the noise margin to be optimized for a given system. The complete dual bus transceiver (SN75453B driver and SN75140 receiver) can be assembled in approximately the same space required by a single 16-pin package and only one power supply is required (5 V). Data in and data out are TTL compatible.

Figure 5. Dual Bus Transceiver

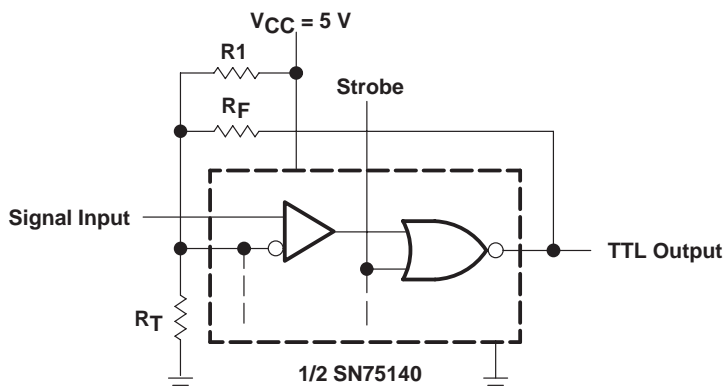
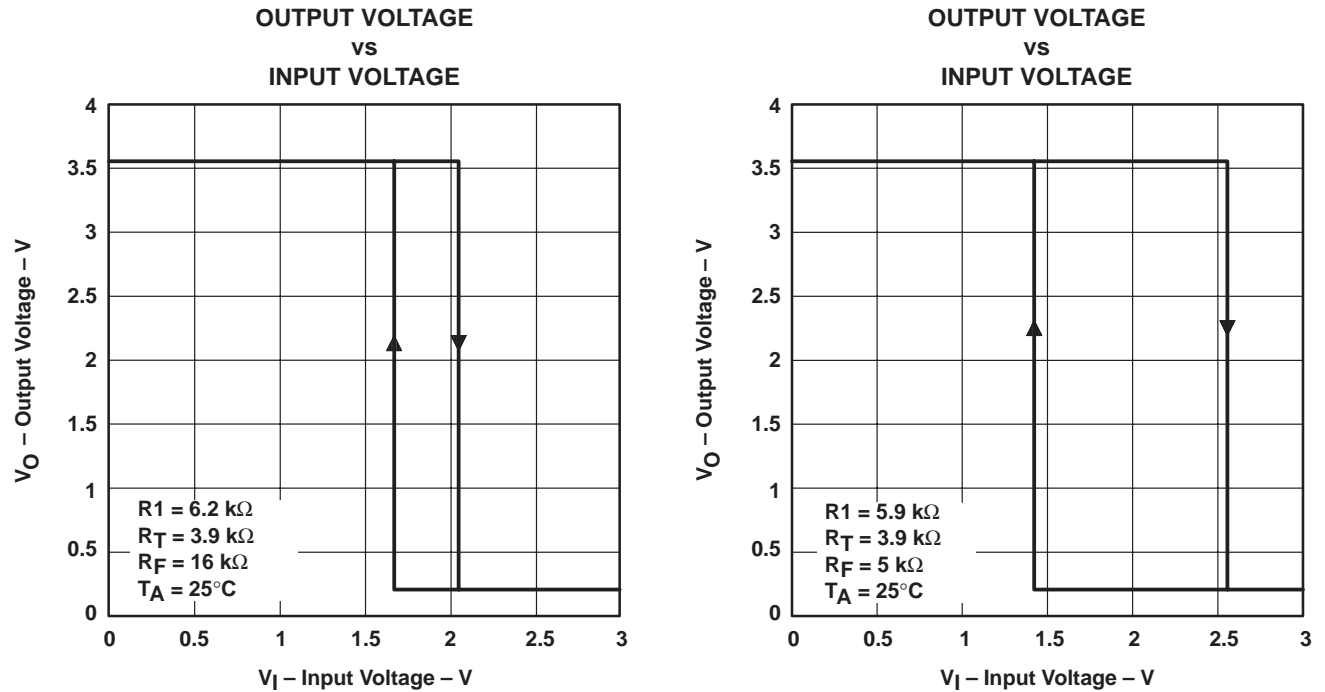


Figure 6. Schmitt Trigger

## APPLICATION INFORMATION



NOTE A: Slowly changing input levels from data lines, optical detectors, and other types of transducers can be converted to standard TTL signals with this Schmitt-trigger circuit.  $R_1$ ,  $R_F$ , and  $R_T$  can be adjusted for the desired hysteresis and trigger levels.

Figure 7. Examples of Transfer Characteristics

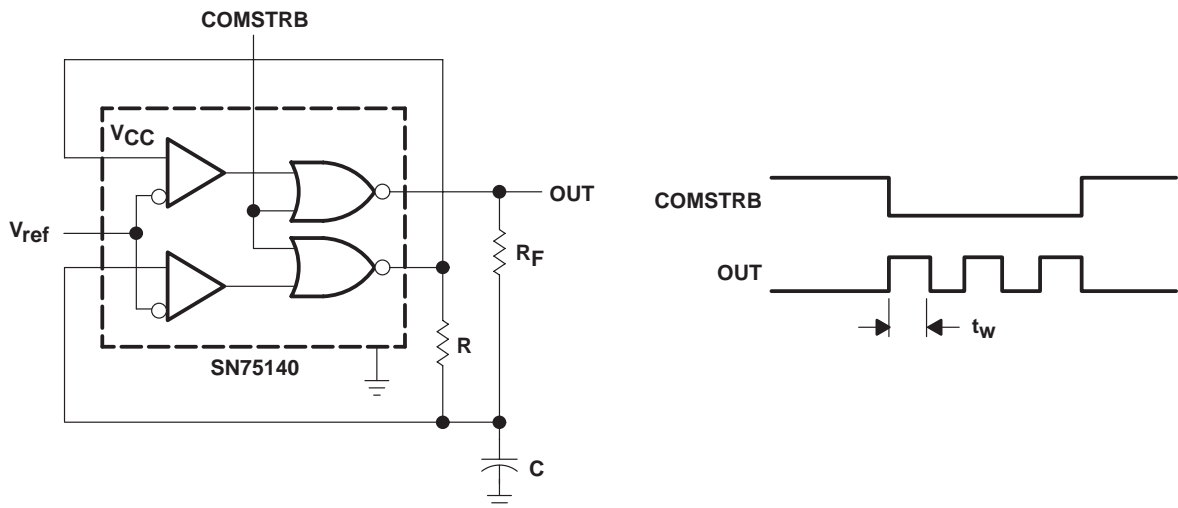


Figure 8. Gated Oscillator

APPLICATION INFORMATION

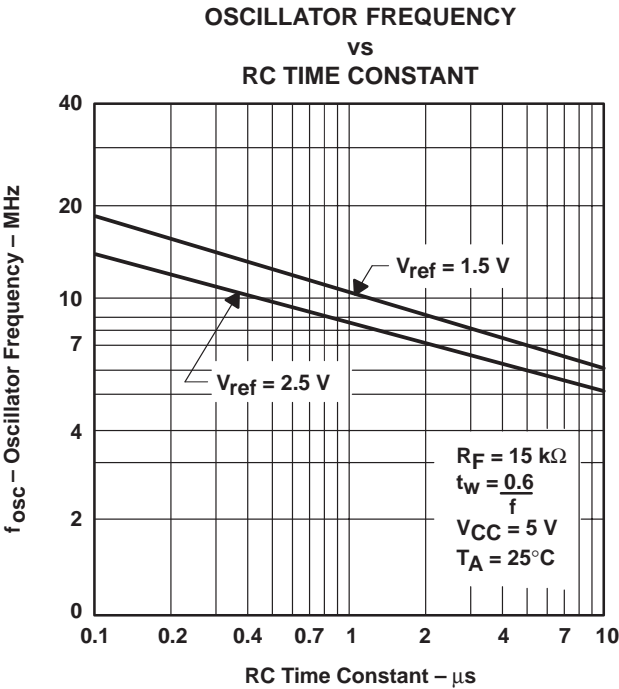


Figure 9



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